Supporting Information:

## In-situ Raman Spectroscopy of Sulfur Speciation in

## Lithium-Sulfur Batteries

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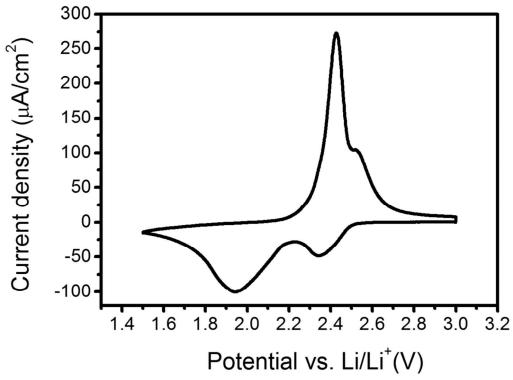


Figure S1. Cyclic voltammetry of the as-prepared sulfur-carbon cathode at a scan rate of 20  $\mu$  V/s in a coin cell.

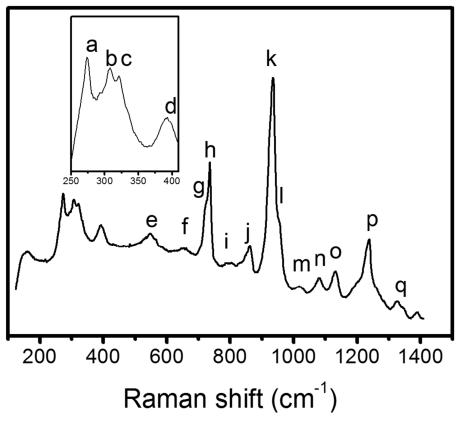


Figure S2. In-situ Raman spectra of the sulfur-carbon cathode shown at 3.2 V in 1M LiTFSI with TEGDME/DIOX (1:1, by vol).

Peak label	Peak position (cm <sup>-1</sup> )	Assignment (cm <sup>-1</sup> )
а	273	CF <sub>3</sub> (rocking mode from TFSI <sup>-</sup> )
b	307	SO <sub>2</sub> (rocking mode from TFSI <sup>-</sup> )
С	321	SO <sub>2</sub> (rocking mode from TFSI <sup>-</sup> )
d	392	SO <sub>2</sub> (wagging mode from TFSI <sup>-</sup> )
е	522-573 (broad peak)	O-C-C (bending mode form TEGDME) CF <sub>3</sub> (bending mode from TFSI <sup>-</sup> )
f	644-661 (broad peak)	SNS (bending mode from TFSI <sup>-</sup> ) Ring deformation from 1,3-Dioxolane
g	722	C-O-C (bending mode from 1,3-Dioxolane)
h	735	CF <sub>3</sub> (bending mode from TFSI <sup>-</sup> )
i	782-810 (broad peak)	C-S (stretching mode from TFSI-)
j	863	CH <sub>2</sub> (rocking mode from TEGDME)
k	934	C-O + C-C (stretching mode from 1,3-Dioxolane)
1	955	C-O (stretching mode from 1,3-Dioxolane)
m	1023	C-O stretching from TEGDME
n	1080	C-O stretching and CH <sub>2</sub> rocking mode from 1,3-Dioxolane
0	1132	SO <sub>2</sub> (stretching mode from TFSI <sup>-</sup> )
р	1237	CH <sub>2</sub> (twisting mode from 1,3-Dioxolane)
q	1325	CH <sub>2</sub> (wagging mode from 1,3-Dioxolane)

Table S1. Vibrational frequencies and assignments for TFSF, TEGDME and DIOX as shown in Figure S2.  $^{\rm 1-4}$ 

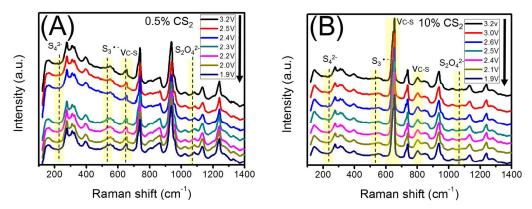


Figure S3. In-situ Raman spectra of sulfur-carbon cathode obtained during discharge with (A) 0.5% CS<sub>2</sub> additive and (B) 10% CS<sub>2</sub> additive (by vol.) at 3.2 V.<sup>5,6</sup>

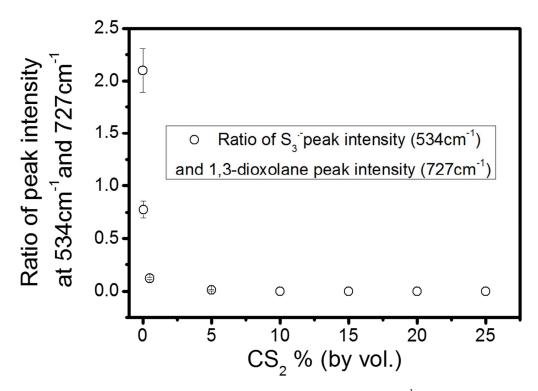


Figure S4. The ratio of maximum peak intensity for  $S_3^{-1}$  (534 cm<sup>-1</sup>) and C-O-C bending mode of 1,3-dioxolane (727 cm<sup>-1</sup>) were plotted as a function of different amounts of CS<sub>2</sub>.

Figure S4 shows the peak intensity ratio of the  $S_3$  peak at 534 cm<sup>-1</sup> and the C-O-C bending mode of 1,3-dioxolane at 727 cm<sup>-1</sup> as a function of different amounts of added CS<sub>2</sub>. The intensity of the 1,3-dioxolane peak at 727 cm<sup>-1</sup> is constant and can S3

be used as an internal standard. This result shows the formation of S<sub>3</sub> in the second

anodic peak is suppressed with CS2 addition. The ratio quickly drops with addition of

as little as 0.05% CS<sub>2</sub> and S<sub>3</sub><sup>--</sup> formation was not observed with 10% or more CS<sub>2</sub>.

## References:

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